| • | SUBSTITUTE FOR | U.S. D | DEPARTMENT OF COMMERCE | Complete if Known | | |
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| 10 | FORM 1449 | . 0.0.2 | Patent and Trademark Office | Application Number | 10/713,409 | |
| \0\'\ | E (085)9) | | | Filing Date | 11/14/2003 | |
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| TRATA | RAUEHRE | (use as many s | heets as necessary) | Examiner Name | | |
| | Sheet 1 1 | | of 1 | Attorney Docket Number | 03226.347001; SUN040249 | |

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| Examiner Signature | TED T. VO | Date Considered | 2/1/07 |
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